



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Tsugio WAKITA et al. Art Unit : 2861
Serial No. : 10/507,412 Examiner : Unknown
Filing Date: September 13, 2004
Title : ANALYSIS APPARATUS AND ANALYSIS DISC USED FOR
THE SAME

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Customer Window
U.S. Patent & Trademark Office
Randolph Building
401 Dulany St.
Alexandria, Virginia 22314

Sir:

Pursuant to 37 C.F.R. 1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached Form PTO-1449. A copy of the reference listed on Form PTO-1449 is attached.

This document was cited in an Office Action in the corresponding Japanese Patent Application No. 2002-069375, which was mailed from the Japanese Patent office on April 11, 2006.

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 C.F.R. 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that this reference be made of record therein and appear among the "References

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Cited" on any patent to issue therefrom.

Respectfully submitted,

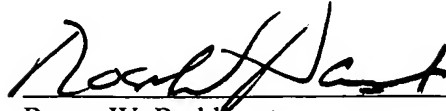
STEPTOE & JOHNSON LLP

May 16, 2006
Date

RWP/lmw

Attorney Docket No.: 28951.5341

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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	Attorney's Docket No. 28951.5341	Application No. 10/507,412
	Applicant Tsugio WAKITA, <i>et al.</i>	
	Filing Date September 13, 2004	Group Art Unit 2861

U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AC	2001-522998	11/20/2001	Japan				X
	AD							
	AE							
	AF							
	AG							
	AH							
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Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AO	
	AP	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	